

Application/Control	No.
10/743.626	

Examiner
Chen-Wen Jiang

Applicant(s)/Patent under Reexamination RAFALOVICH ET AL.

Art Unit 3744

	ORIO	SINAL		INTERNATIONAL CLASSIFICATION										
1	CLASS	LASS			Cl	AIMED		. NON-CLAIMED						
	62 .	99	F	25	В	5	/00			. 1				
	CROSS RE	FERENCES												
CLASS	SUBCLASS (ONE SUBCLASS P	ER BLOCK)								<u> </u>			
62	200						1			1				
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(Assi	stant Examiner)	CHE	CHENWEN JIANG					Total Claims Allowed: 7						
	struments Exam	CHENWEN JIANG CHENWEN JIANG (PRIMARY EXAMINE) (Primary Examiner) (Date)			(Date)	•	O.G. Print Clair	n(s)	O.G. Print Fig					

	Claims renumbered in the same order as presented by applicant								□СРА			☐ T.D.		☐ R.1.47					
Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original
1	1			31			61			91			121			151			181
	2		·	32			62			92			122			152			182
	3]		33			63			93			123			153			183
	4			34			64			94			124			154			184
	5			35			65			95			125			155			185
	6			36			66			96			126			156			186
	7			37			67			97			127	1		157			187
	8			38			68			98			128			158			188
	9			39			69			99			129			159			189
	10			40			70			100			130			160	0.77		190
	11			41			71			101	24.3		131			161			191
	12	1		42			72			102			132			162			192
	13			43			73	}		103			133			163			193
2	14	1		44			74			104			134			164			194
4	15			45			75			105			135			165			195
5	16			46			76			106			136			166			196
6	17			47			77			107			137			167			197
7	18			48			78	}		108			138			168	t.		198
3	19			49			. 79			109			139			169			199
	20			50			80			110			140			170			200
	21			51			81			111			141			171			201
	22			52			82	}		112			142			172			202
	23			53			83			113			143			173			203
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	25		100	55			85			115	1		145			175			205
	26			56			86			116			146			176			206
	27			57			87			117			147			177	ľ l		207
	28			58			88			118			148			178			208
	29			59			89			119			149	1		179			209
	30			60			90			120			150			180			210